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AP3 Rec'd PCT/PTO 07 JUN 2006

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of: Youichi ARAI.

Serial Number: Not Yet Assigned
(§371 of International Application PCT/JP05/00679)

Filed: June 7, 2006

For. **METHOD OF MEASURING INTRINSIC RESISTANCE OF BATTERY
AND APPARATUS OF SAME**

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

June 7, 2006

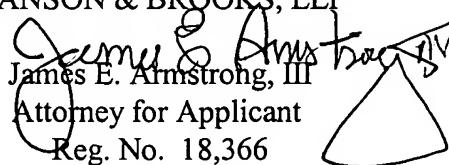
Sir:

In compliance with 37 CFR 1.56, Applicant calls to the attention of the Patent and Trademark Office the references listed on the attached PTO-1449 and cited in the enclosed international search report. References AE-AF are cited in the international search report.

A copy of each of the references is enclosed herewith.

In the event there are any fees due in connection with the filing of this paper, please charge Deposit Account No. 01-2340.

Respectfully submitted,
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PATENT TRADEMARK OFFICE

Enclosures: PTO-1449; References (3); International Search Report

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INFORMATION DISCLOSURE STATEMENT PTO-1449	Atty. Docket No. 060424	Serial No. New Application
Applicant(s): Youichi ARAI		
	Filing Date: June 7, 2006	Group Art Unit: Not Yet Assigned

U.S. PATENT DOCUMENTS

Examiner Initial	Document No.	Name	Date	Class	Subclass	Filing Date (If appropriate)
_____	AA					
_____	AB					
_____	AC					
_____	AD					

FOREIGN PATENT DOCUMENTS

	Document No.	Date	Country	Translation (Yes or No)
_____	AE	2003-177163	06/27/03	Japan No
_____	AF	2003-177164	06/27/03	Japan No
_____	AG	2003-115331	04/18/03	Japan Yes-Abstract/Discussed in the specification
_____	AH			
_____	AI			

OTHER DOCUMENTS

_____	AJ	
_____	AK	

Examiner Date Considered